

TOSHIBA Transistor Silicon NPN Epitaxial Type

2SC5906

High-Speed Switching Applications
 DC-DC Converter Applications
 Strobe Applications

- High DC current gain: $h_{FE} = 200$ to 500 ($I_C = 0.5$ A)
- Low collector-emitter saturation voltage: $V_{CE(sat)} = 0.2$ V (max)
- High-speed switching: $t_f = 25$ ns (typ.)

Absolute Maximum Ratings ($T_a = 25^\circ\text{C}$)

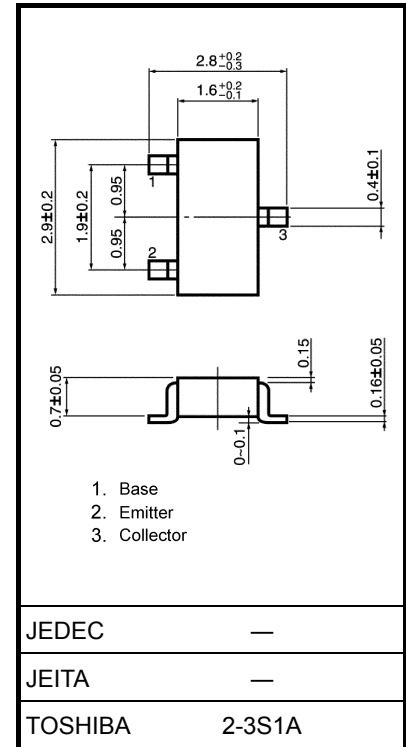
Characteristics		Symbol	Rating	Unit
Collector-base voltage		V_{CBO}	50	V
Collector-emitter voltage		V_{CEX}	50	V
Collector-emitter voltage		V_{CEO}	30	V
Emitter-base voltage		V_{EBO}	7	V
Collector current	DC	I_C	4	A
	Pulse	I_{CP}	7	
Base current		I_B	0.4	A
Collector power dissipation	DC	P_C (Note 1)	0.8	W
	$t = 10$ s		1.25	
Junction temperature		T_j	150	$^\circ\text{C}$
Storage temperature range		T_{stg}	-55 to 150	$^\circ\text{C}$

Note 1: Mounted on an FR4 board (glass epoxy, 1.6 mm thick, Cu area: 645 mm²)

Note 2: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Unit: mm



Weight: 0.01 g (typ.)

Electrical Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Collector cut-off current	I_{CBO}	$V_{CB} = 50\text{ V}, I_E = 0$	—	—	0.1	μA
Emitter cut-off current	I_{EBO}	$V_{EB} = 7\text{ V}, I_C = 0$	—	—	0.1	μA
Collector-emitter breakdown voltage	$V_{(BR)CEO}$	$I_C = 10\text{ mA}, I_B = 0$	30	—	—	V
DC current gain	$h_{FE}(1)$	$V_{CE} = 2\text{ V}, I_C = 0.5\text{ A}$	200	—	500	
	$h_{FE}(2)$	$V_{CE} = 2\text{ V}, I_C = 1.6\text{ A}$	120	—	—	
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = 1.6\text{ A}, I_B = 53\text{ mA}$	—	—	0.20	V
Base-emitter saturation voltage	$V_{BE(sat)}$	$I_C = 1.6\text{ A}, I_B = 53\text{ mA}$	—	—	1.10	V
Collector output capacitance	C_{ob}	$V_{CB} = 10\text{ V}, I_E = 0, f = 1\text{ MHz}$	—	35	—	pF
Switching time	Rise time	t_r	—	55	—	ns
	Storage time	t_{stg}	—	310	—	
	Fall time	t_f	—	25	—	

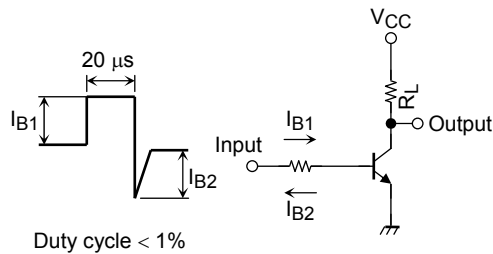
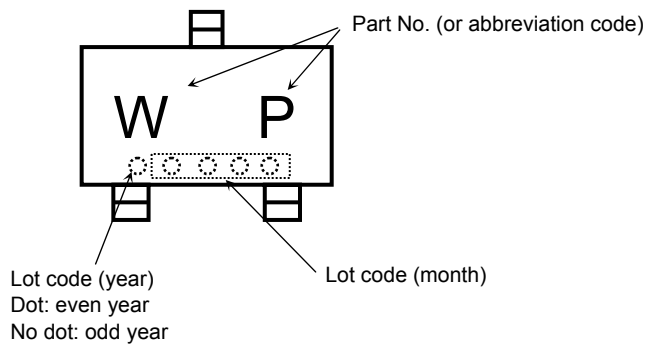
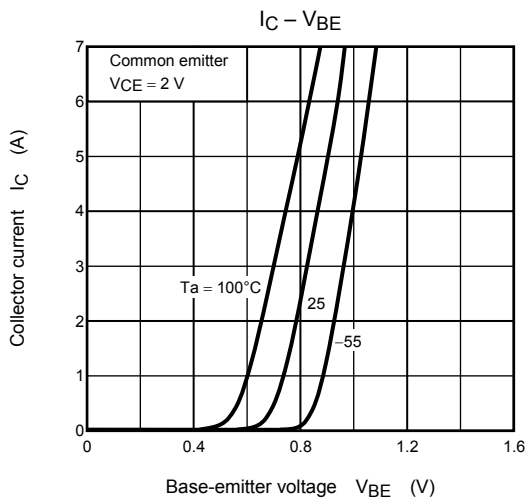
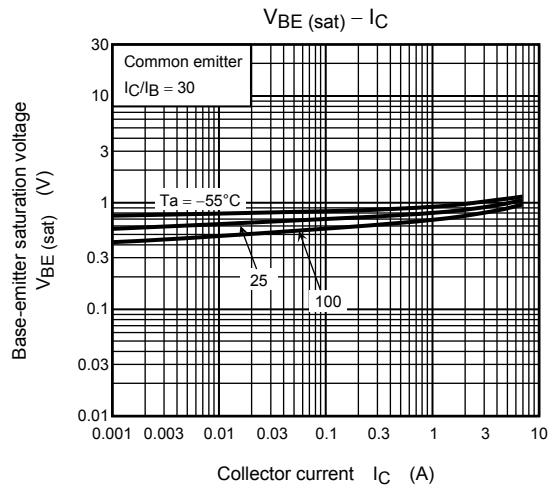
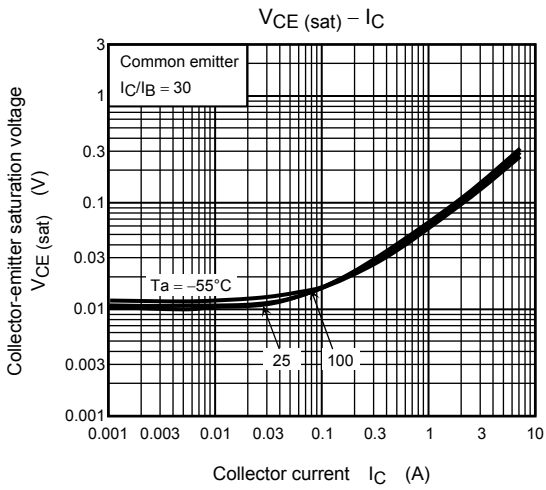
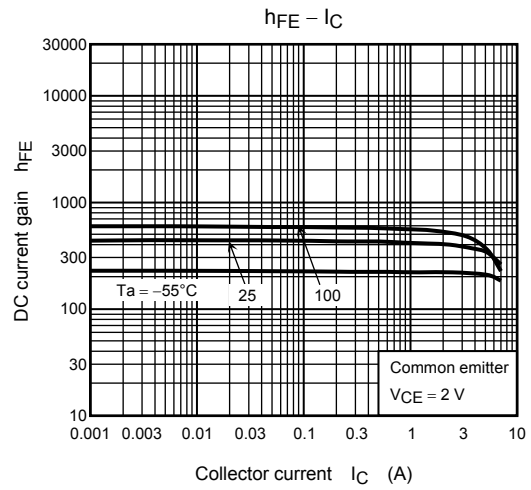
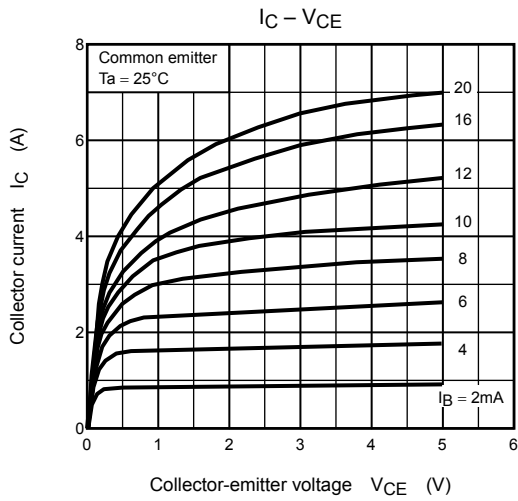
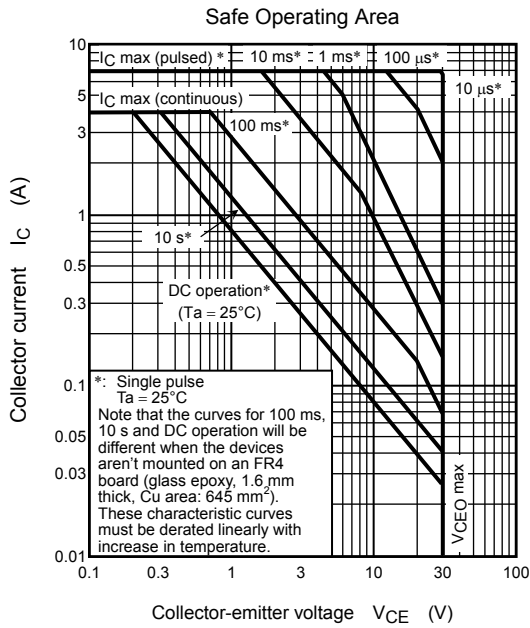
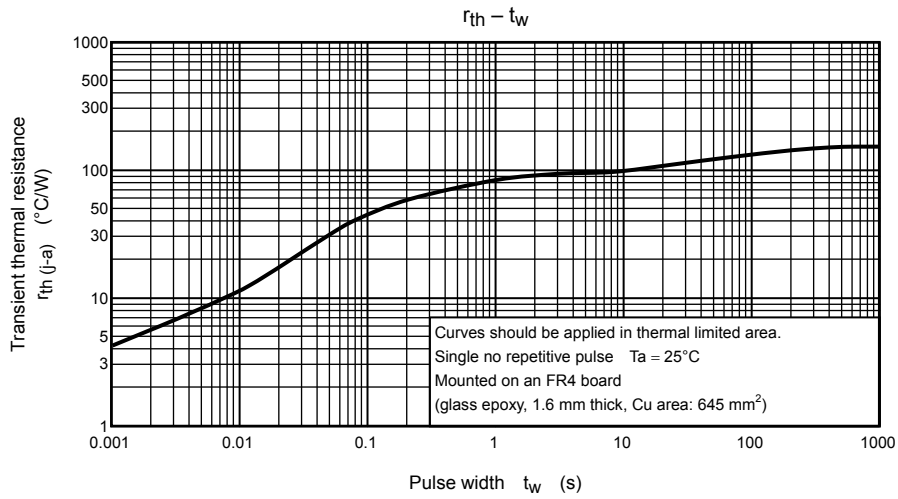


Figure 1 Switching Time Test Circuit & Timing Chart

Marking







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